

SEMITOP®E1

3-phase Converter-Inverter-Brake (CIB)

Engineering Sample SK30DGDL07E3ETE1

Target Data

Features*

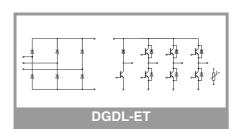
- Optimized design for superior thermal performance
- Low inductive design
- · Press-Fit contact technology
- 650V Trench IGBT3 (E3)
- Robust and soft switching CAL4F diode technology
- PEP rectifier diode technology for enhanced power and environmental robustness
- Integrated NTC temperature sensor
- UL recognized file no. E 63 532

Typical Applications

- Motor drives
- Air conditioning
- Auxiliary Inverters

Remarks

Absolute	Maximum Rating	s		
Symbol	Conditions		Values	Unit
Inverter -	IGBT			•
V _{CES}	T _j = 25 °C		650	V
Ic	λ _{paste} =0.8 W/(mK)	T _s = 25 °C	38	Α
	T _j = 175 °C	T _s = 70 °C	31	Α
I _C	λ _{paste} =2.5 W/(mK)	T _s = 25 °C	44	Α
	T _j = 175 °C	T _s = 70 °C	36	Α
I _{Cnom}			30	Α
I _{CRM}			60	Α
V _{GES}			-20 20	V
t _{psc}	$V_{CC} = 360 \text{ V}$ $V_{GE} \le 15 \text{ V}$ $V_{CES} \le 650 \text{ V}$	T _j = 150 °C	6	μs
Tj		1	-40 175	°C
Chopper	- IGBT		•	
V _{CES}	T _j = 25 °C		650	V
Ic	$\lambda_{\text{paste}} = 0.8 \text{ W/(mK)}$	T _s = 25 °C	38	Α
	T _j = 175 °C	T _s = 70 °C	31	Α
Ic	λ _{paste} =2.5 W/(mK)	T _s = 25 °C	44	Α
	T _j = 175 °C	T _s = 70 °C	36	Α
I _{Cnom}		<u> </u>	30	Α
I _{CRM}			60	Α
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Tj		1	-40 175	°C
Inverse -	Diode		-	<u>_</u>
V _{RRM}	T _j = 25 °C		650	V
I _F	λ _{paste} =0.8 W/(mK)	T _s = 25 °C	33	А
	T _j = 175 °C	T _s = 70 °C	26	Α
I _F	λ _{paste} =2.5 W/(mK)	T _s = 25 °C	37	Α
	T _j = 175 °C	T _s = 70 °C	29	Α
I _{FRM}			60	Α
I _{FSM}	$t_p = 10 \text{ ms}, \sin 180$	°, T _i = 150 °C	150	Α
T _i	r	•	-40 175	°C
	eling - Diode			
V _{RRM}	T _i = 25 °C		650	V
I _F	$\lambda_{\text{paste}} = 0.8 \text{ W/(mK)}$	T _s = 25 °C	33	А
	T _i = 175 °C	T _s = 70 °C	26	Α
I _F	λ_{paste} =2.5 W/(mK)	T _s = 25 °C	37	A
•	$T_i = 175 ^{\circ}\text{C}$	T _s = 70 °C	29	A
I _{FRM}	,	1 3	60	A
I _{FSM}	$t_p = 10 \text{ ms, sin } 180$	°. T _i = 150 °C	150	A
Tj	-p	, .,	-40 175	°C
' J	1		70 173	





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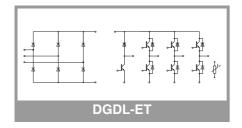
Typical Applications

- Motor drives
- Air conditioning
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Remarks

Absolute Maximum Ratings						
Symbol	Conditions		Values	Unit		
Rectifier -	Diode			·		
V_{RRM}	T _j = 25 °C		1600	V		
l _F	λ_{paste} =0.8 W/(mK) T _j = 175 °C	T _s = 25 °C	59	А		
		T _s = 70 °C	46	А		
I _F	λ_{paste} =2.5 W/(mK) T _j = 175 °C	T _s = 25 °C	70	Α		
		T _s = 70 °C	55	А		
I _{FSM}	$t_p = 10 \text{ ms}$	T _j = 25 °C	370	А		
	sin 180°	T _j = 150 °C	270	Α		
i ² t	$t_p = 10 \text{ ms}$ $\sin 180^\circ$	T _j = 25 °C	685	A ² s		
		T _j = 150 °C	365	A ² s		
T _j			-40 175	°C		
Module						
I _{t(RMS)}	, $\Delta T_{terminal}$ at PCB joint = 30 K, per pin		30	Α		
T _{stg}	module without TIM		-40 125	°C		
V _{isol}	AC, sinusoidal, 1 min		2500	V		

Characteristics							
Symbol	Conditions		min.	typ.	max.	Unit	
Inverter -	IGBT		•			•	
V _{CE(sat)}	$I_C = 30 \text{ A}$	T _j = 25 °C		1.45	1.87	V	
	V _{GE} = 15 V chiplevel	T _j = 150 °C		1.70	2.10	V	
V_{CE0}	chiplevel	T _j = 25 °C		0.90	1.00	V	
	Chipievei	T _j = 150 °C		0.82	0.90	V	
r _{CE}	V _{GE} = 15 V	T _j = 25 °C		18	29	mΩ	
	chiplevel	T _j = 150 °C		29	40	mΩ	
$V_{GE(th)}$	$V_{GE} = V_{CE}, I_{C} = 0.43 \text{ mA}$		5.1	5.8	6.4	V	
I _{CES}	$V_{GE} = 0 \text{ V}, V_{CE} = 65$	0 V, T _j = 25 °C			0.3	mA	
C _{ies}	V 05.V	f = 1 MHz		1.63		nF	
C _{oes}	$V_{GF} = 0 V$	f = 1 MHz		0.108		nF	
C _{res}		f = 1 MHz		0.05		nF	
Q_{G}	V _{GE} = -15V15V			300		nC	
R _{Gint}	T _i = 25 °C			0		Ω	
t _{d(on)}	V _{CC} = 300 V	T _j = 150 °C		14		ns	
t _r	$I_{\rm C} = 30 \text{ A}$	T _j = 150 °C		24		ns	
E _{on}	$R_{G \text{ on}} = 8.2 \Omega$ $R_{G \text{ off}} = 8.2 \Omega$ $di/dt_{on} = 1360 \text{ A/}\mu\text{s}$	T _j = 150 °C		0.51		mJ	
t _{d(off)}		T _j = 150 °C		152		ns	
t _f	$di/dt_{off} = 436 \text{ A/}\mu\text{s}$	T _j = 150 °C		35		ns	
E _{off}	dv/dt = 5210 V/μs V _{GE} = +15/-15 V	T _j = 150 °C		1.01		mJ	
$R_{th(j-s)}$	per IGBT, λ _{paste} =0.8 W/(mK)			1.57		K/W	
$R_{th(j-s)}$	per IGBT, λ _{paste} =2.5 W/(mK)			1.23		K/W	





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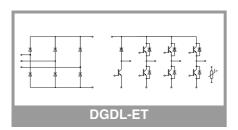
Features*

- Optimized design for superior thermal performance
- · Low inductive design
- Press-Fit contact technology
- 650V Trench IGBT3 (E3)
- Robust and soft switching CAL4F diode technology
- PEP rectifier diode technology for enhanced power and environmental robustness
- Integrated NTC temperature sensor
- UL recognized file no. E 63 532

Typical Applications

- Motor drives
- Air conditioning
- Auxiliary Inverters

Remarks



Characte	ristics					
Symbol	Conditions		min.	typ.	max.	Unit
Chopper	- IGBT					
V _{CE(sat)}	I _C = 30 A	T _i = 25 °C		1.45	1.87	V
o_(oat)	V _{GE} = 15 V	T _j = 150 °C	!	1.70	2.10	V
V	chiplevel					V
V _{CE0}	chiplevel	$T_j = 25 ^{\circ}\text{C}$ $T_i = 150 ^{\circ}\text{C}$		0.90	1.00	V
_	V 45.V	,		0.82	0.90	
r _{CE}	V _{GE} = 15 V chiplevel	$T_j = 25 ^{\circ}\text{C}$ $T_i = 150 ^{\circ}\text{C}$		18	29	mΩ
W	$V_{GE} = V_{CE}, I_C = 0.43$		<i>E</i> 1	29	40	mΩ V
V _{GE(th)}	$V_{GE} = V_{CE}, I_C = 0.43$ $V_{GE} = 0 V, V_{CE} = 65$		5.1	5.8	0.3	
I _{CES}	V _{GE} = 0 V, V _{CE} = 03	f = 1 MHz		1.63	0.3	mA nF
Cies	V _{CE} = 25 V	f = 1 MHz		0.108		nF
C _{oes}	$V_{GE} = 0 V$	f = 1 MHz		0.108		nF
	V _{GE} = -15V +15V					
Q _G	V _{GE} = -15V +15V T _i = 25 °C			300		nC Ω
R _{Gint}	$V_{CC} = 300 \text{ V}$	T _i = 150 °C		14		ns
t _{d(on)}	I _C = 30 A	T _i = 150 °C		24		
t _r E _{on}	$R_{G \text{ on}} = 8.2 \Omega$	T _i = 150 °C		0.51		ns mJ
	$R_{G \text{ off}} = 8.2 \Omega$,		152		
t _{d(off)}	$di/dt_{on} = 1360 \text{ A/}\mu\text{s}$ $di/dt_{off} = 436 \text{ A/}\mu\text{s}$	T _i = 150 °C		35		ns
t _f	dv/dt = 5200 V/μs	1) = 130 C		- 55		ns
E _{off}	$V_{GE} = +15/-15 \text{ V}$	T _j = 150 °C		1.01		mJ
R _{th(j-s)}	per IGBT, λ _{paste} =0.8 W/(mK)			1.57		K/W
R _{th(j-s)}	per IGBT, λ _{paste} =2.5	5 W/(mK)		1.23		K/W
Inverse -	Diode					
$V_F = V_{EC}$	I _F = 30 A	T _j = 25 °C		1.60	2.06	V
	chiplevel	T _j = 150 °C		1.69	2.21	V
V_{F0}	chiplevel	T _j = 25 °C		1.04	1.24	V
	op.ovo.	T _j = 150 °C		0.85	0.99	V
r _F	chiplevel	T _j = 25 °C		19	27	mΩ
		T _j = 150 °C		28	41	mΩ
I _{RRM}	$I_F = 30 \text{ A}$	T _j = 150 °C		38		Α
Q_{rr}	di/dt _{off} = 1360 A/μs V _{GE} = -15 V			1.71		μС
E_{rr}	V _{CC} = 300 V	T _j = 150 °C		0.17		mJ
$R_{th(j-s)}$	per Diode, λ _{paste} =0.	8 W/(mK)		2.07		K/W
$R_{th(j-s)}$	per Diode, λ_{paste} =2.	5 W/(mK)		1.71		K/W
Freewhee	eling - Diode					
$V_F = V_{EC}$	I _F = 30 A	T _j = 25 °C		1.60	2.06	V
	chiplevel	T _j = 150 °C		1.69	2.21	V
V _{F0}	chiplevel	T _j = 25 °C		1.04	1.24	V
	Of IIPIOVOI	T _j = 150 °C		0.85	0.99	V
r _F	chiplevel	T _j = 25 °C		19	27	mΩ
		T _j = 150 °C		28	41	mΩ
I _{RRM}	I _F = 30 A	T _j = 150 °C		38		Α
Q_{rr}	di/dt _{off} = 1360 A/μs V _{GE} = -15 V	T _j = 150 °C		1.71		μC
Err	$V_{GE} = -15 \text{ V}$ $V_{CC} = 300 \text{ V}$	T _j = 150 °C		0.17		mJ
R _{th(j-s)}	per Diode, $\lambda_{paste}=0$.	8 W/(mK)		2.07		K/W
R _{th(j-s)}	per Diode, $\lambda_{paste}=2$.			1.71		K/W
0)	. paote	l			1	



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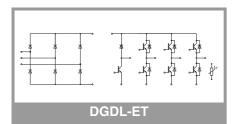
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Typical Applications

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Remarks

Characte	ristics					
Symbol	Conditions		min.	typ.	max.	Unit
Rectifier -	Diode					
V _F	I _F = 30 A	T _j = 25 °C		1.07	1.34	V
	chiplevel	T _j = 150 °C		0.99	1.27	V
V_{F0}	chiplevel	T _j = 25 °C		0.89	1.09	V
	chipievei	T _j = 150 °C		0.73	0.92	V
r _F	chiplevel	T _j = 25 °C		6.2	8.5	mΩ
		T _j = 150 °C		8.8	12	mΩ
I _R	T _j = 150 °C, V _{RRM}				2	mA
R _{th(j-s)}	per Diode, λ _{paste} =0.8 W/(mK)			1.55		K/W
R _{th(j-s)}	per Diode, λ _{paste} =2.5 W/(mK)			1.19		K/W
Module						
Ms	to heatsink		1.6		2.3	Nm
W				25		g
L _{CE}				30		nH
Temperat	ure Sensor					
R ₁₀₀	T _c =100°C (R ₂₅ =5 kΩ)			493 ± 5%		Ω
B _{25/85}	$R_{(T)} = R_{25} * \exp[B_{25/85} * (1/T-1/298)], T[K]$			3420		K



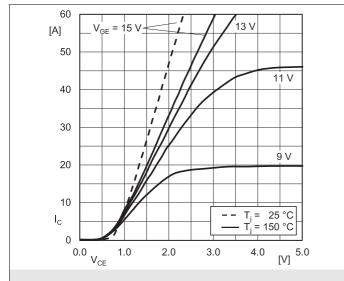


Fig. 1: Typ. IGBT output characteristic, incl. R_{CC+ EE}

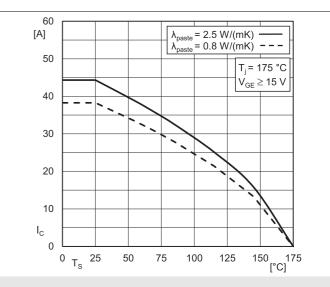


Fig. 2: IGBT rated current vs. temperature I_c=f(T_s)

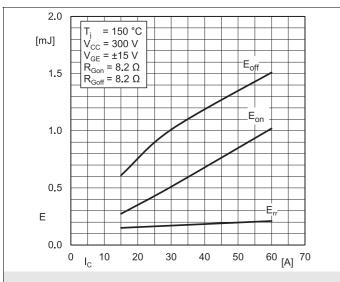


Fig. 3: Typ. turn-on /-off energy = $f(I_C)$

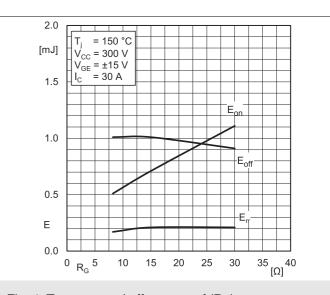


Fig. 4: Typ. turn-on /-off energy = $f(R_G)$

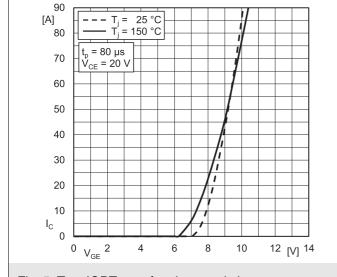


Fig. 5: Typ. IGBT transfer characteristic

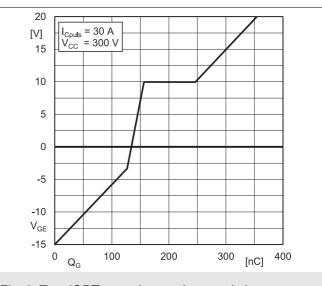
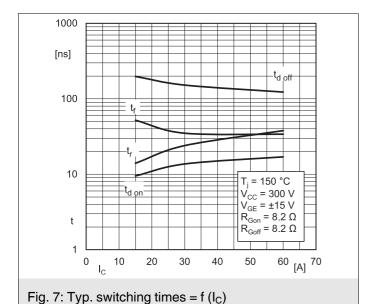
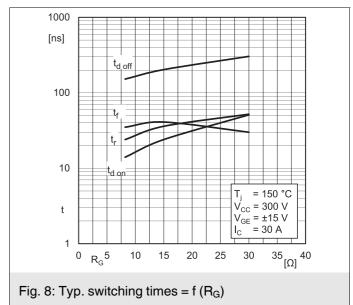
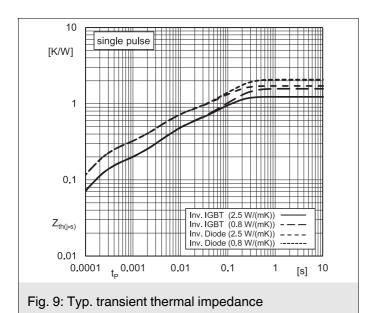
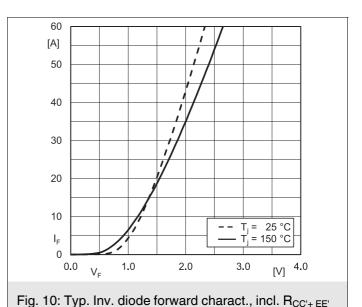


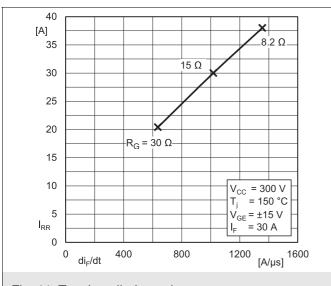
Fig. 6: Typ. IGBT gate charge characteristic











 $V_{CC} = 300 \text{ V}$ [µC] T_j = 100 V_{GE} = ±15 V = 150 °C 60 A 2.0 15 Ω 8.2 Ω $R_G = 30 \Omega$ 30 A 1.5 $I_F = 15 A$ 1.0 0.5 Q_{rr} 0.0 [A/µs] 1800 600 1200 di_F/dt

Fig. 11: Typ. Inv. diode peak reverse recovery current

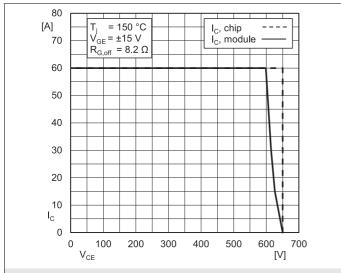


Fig. 13: IGBT Reverse Bias Safe Operating Area (RBSOA)

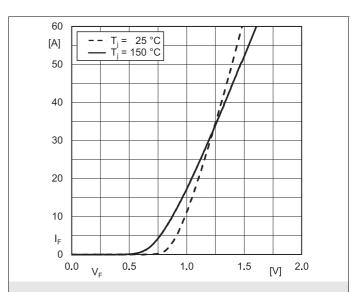
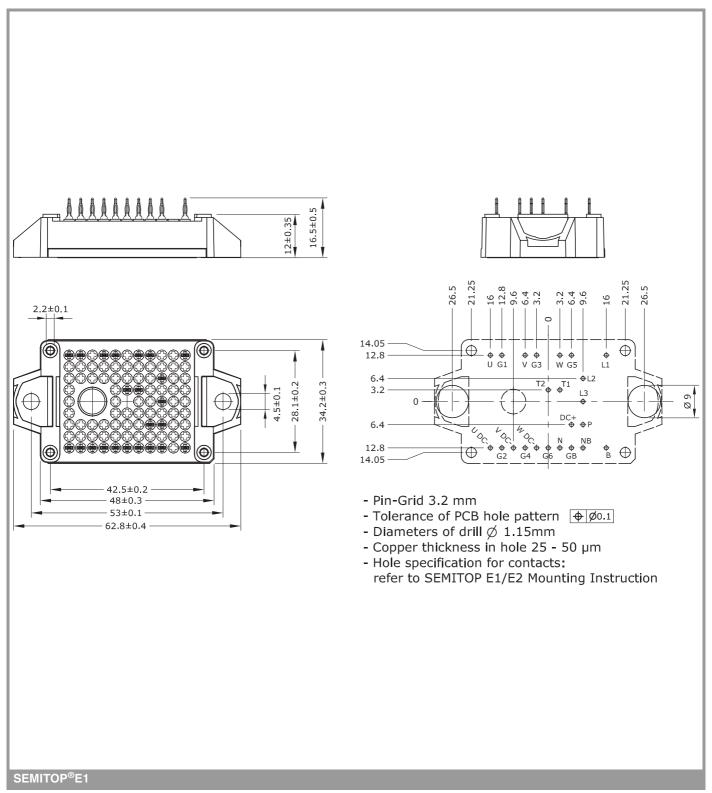
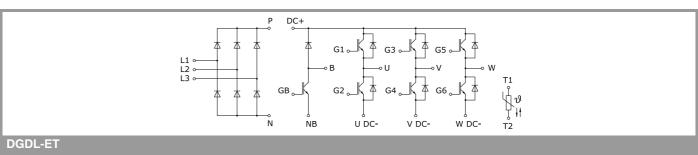


Fig. 14: Typ. Rect. diode forward charact., incl. $R_{CC'+EE'}$





This is an electrostatic discharge sensitive device (ESDS) due to international standard IEC 61340.

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